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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination KOC ET AL. | |
| | | Examiner Howard L. Williams | Art Unit 2819 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|--|-----------------|----------------------|----------------|
| * | A | US-2002/0118128 A1 | 08-2002 | Siferd, Raymond E. | 341/141 |
| * | B | US-2004/0164887 A1 | 08-2004 | Skones et al. | 341/144 |
| * | C | US-5,619,536 A | 04-1997 | Gourgue, Frederic | 375/316 |
| * | D | US-6,469,649 B1 | 10-2002 | Helkey et al. | 341/155 |
| * | E | US-6,518,905 B2 | 02-2003 | Siferd, Raymond E. | 341/143 |
| * | F | US-6,538,588 B1 | 03-2003 | Bazarjani, Seyfollah | 341/143 |
| * | G | US-6,977,602 B1 | 12-2005 | Ostrem et al. | 341/145 |
| H | US- | | | | |
| I | US- | | | | |
| J | US- | | | | |
| K | US- | | | | |
| L | US- | | | | |
| M | US- | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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